

Application/Control No.	Applicant(s)/Patent under Reexamination
10/560,051	OKABE ET AL.
Examiner	Art Unit
Son T. Nauven	3643

SEARCHED					
Class	Subclass	Date	Examiner		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH I (INCLUDING SEAR	NOTES CH STRATEGY)
	DATE	EXMR
previous search updated	11/2/2009	stn